

Notice of References Cited

Application/Control No.

10/572,725

Applicant(s)/Patent Under
Reexamination
HAN ET AL.

Examiner

PING Y. HSIEH

Art Unit

2618

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0119467 A1	06-2003	Welland et al.	455/260
*	B	US-2004/0048591 A1	03-2004	Kim et al.	455/168.1
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

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